

<b>Notice of References Cited</b>	Application/Control No. 10/826,712	Applicant(s)/Patent Under Reexamination CHU ET AL.	
	Examiner Edward J Wojciechowicz	Art Unit 2815	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0000242	01-2002	Matushiita et al.	136/244
	B	US-6,100,166	08-2000	Sakaguchi et al.	438/455
	C	US-6,350,945	02-2002	Mizuno, Shinichi	136/246
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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**NON-PATENT DOCUMENTS**

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